Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/532,619	CHEN, ERNEST C.
Examiner	**Art Unit**
Emmanuel Bayard	2611

SEARCHED			
Class	Subclass	Date	Examiner
375	265	6/15/2007	EB
375	295	6/15/2007	EB
375	299	6/15/2007	EB
375	316	6/15/2007	EB
375	340	6/15/2007	EB
375	349	6/15/2007	EB

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East	6/15/2007	EB